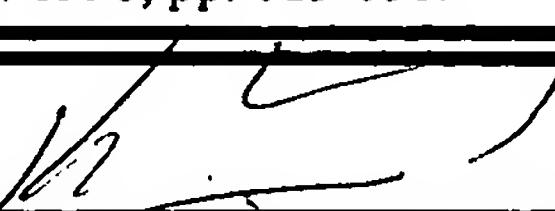


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U.S. PATENT DOCUMENTS							
Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Appropriate
✓	AA	US 6424238 B1	07-2002	Penunuri, David	333	187	01-08-2001
✓	AB	US 5903820	05-1999	Hagstrom, Panu	455	82	04-03-1996
✓	AC	US 5928598	07-1999	Anderson et al.	264	446	05-09-1997
✓	AD	US6417026 B2	07-2002	Gotoh et al.	438	108	01-05-2001
✓	AE	US5465409	11-1995	Borras et al.	455	84	03-07-1994
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Initial		Document Number	Date	Country	Class	Sub-Class	Translation
							Yes
✓	AK						
Other Documents (Title, Author, Date, Pages, Etc., if known)							
✓	AL	Senju Metal Industry Co., Ltd., SMIC Technical Bulletin – SPARKLE BALL for BGA, CSP, Flip Chip Application, Issued October, 1997, page 3, http://www.senjucotek.com/Sphere_Tech_Bulletin.pdf					
✓	AM	H. Yatsuda and T. Eimura, "Flip-Chip Assembly Technique for SAW Devices", <i>ISHM '95 Proceedings</i> , pp. 003-008.					
✓	AN	Shuji Suma, Katsuhiro Gunji, Toshio Tagami and Yoshinobu Sakamoto, "Surface Mount Type SAW Filter For Hand-Held Telephones", <i>IEEE Ultrasonics Symposium</i> , 1995, pp. 1-6.					
✓	AO	Hiromi Yatsuda, Taira Horishima, Takeshi Eimura and Takao Ooiwa, "Miniaturized SAW Filters Using A Flip-Chip Technique", <i>IEEE Transactions on Ultrasonics, Ferroelectrics, and Frequency Control</i> , Vol.43, no.1, Jan. 1996, pp. 125-130.					
Examiner's Signature 				Date Considered: 3/31/05			
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